Recurrent Localization Networks applied to the Lippman_fSchwinger Equation



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BACKGROUND:

- Designing new materials requires linkages between process, structure, and property
- Estimating and understanding these linkages involves testing and simulation
- Simulating physics over high-dimensional structures is expensive
- Machine learning models are faster than traditional simulations, but less accurate and interpretable
- Physics-informed learning is a rapidlygrowing field

METHODS

- Convert governing equation to equivalent
 Lippman-Schwinger (L-S) form
- 2. Approximate L-S operator with an ML model and solve iteratively
- 3. Train end-to-end on synthetic data
- 4. Result: learned L-S iteration!

RESULTS

- $\approx 1000 \text{X}$ speedup over FEA baseline
- More accurate and efficient than standard deep learning models
- Iterative model was more powerful than a single feed-forward network with identical structure and number of parameters

CONCLUSIONS & FUTURE WORK

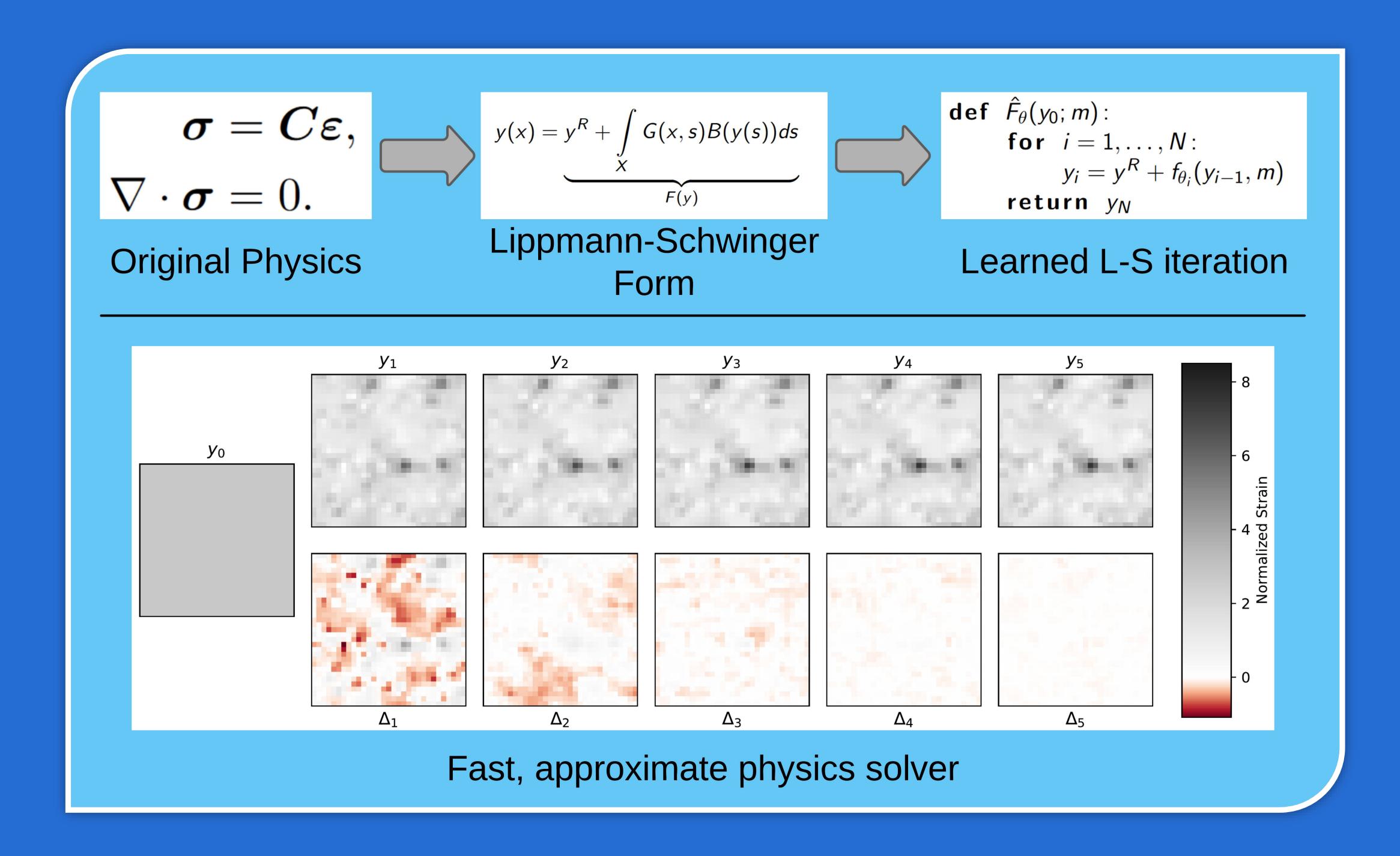
- Baking physics into a learning method creates more efficient and accurate models
- Recurrent, fully-convolutional networks are excellent for modeling physical systems
- Gradient-based formulation allows for property optimization through MLmodel

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Embedding physics into machine learning creates better models. These models can accelerate the development of new materials.





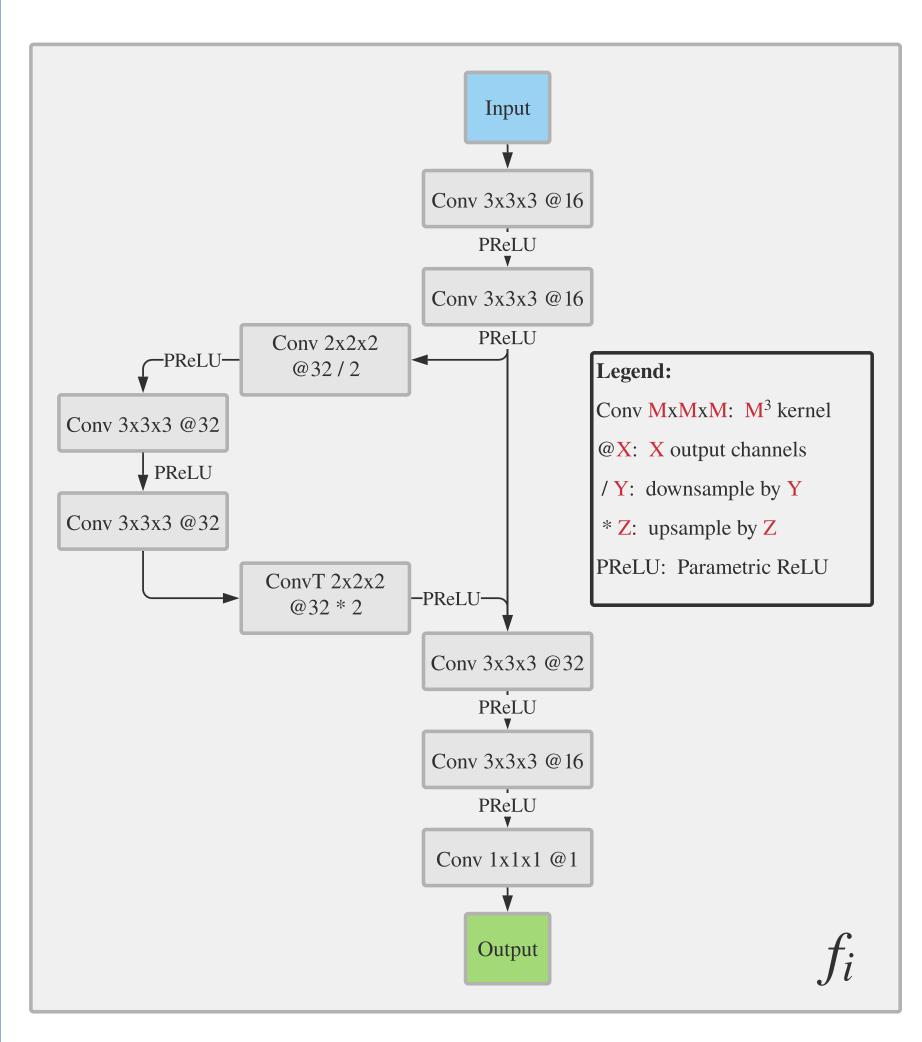


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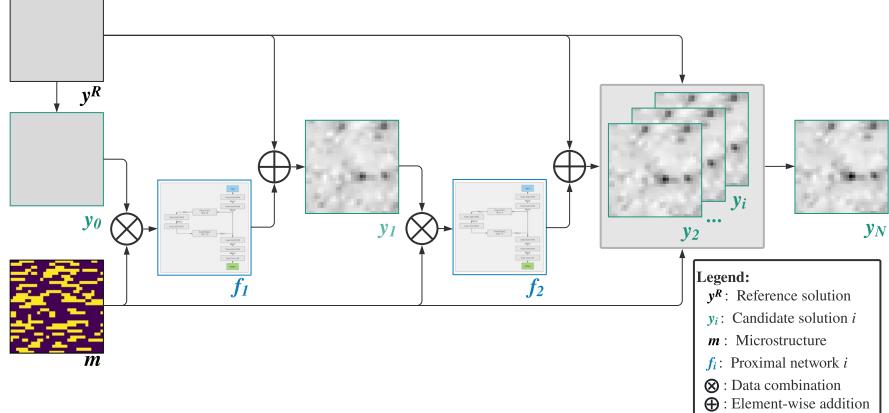




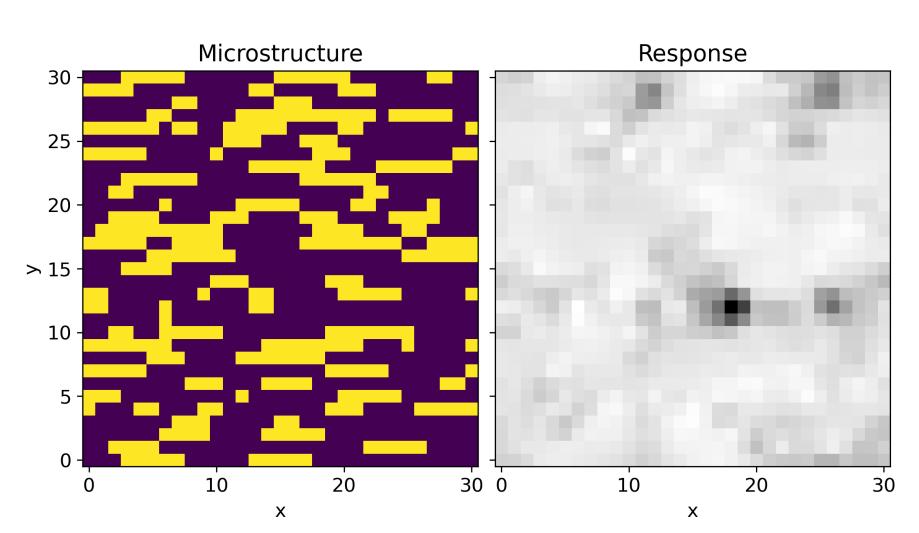




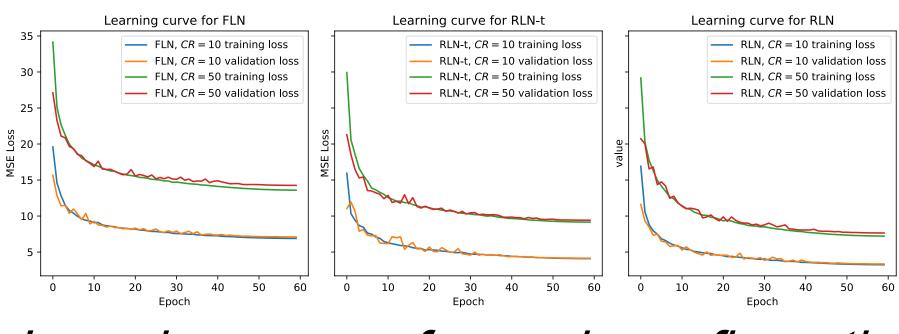








Example input/output pair



Learning curves for each configuration

Model	MASE (mean \pm std. dev.)
Contrast-10	
Comparison DL model [11]	3.07%±1.22%
FLN	4.98%±1.49%
RLN-t	$1.81\% \pm 0.58\%$
RLN	1.21%±0.37%
Contrast-50	
Comparison DL model	5.71%±2.46%
FLN	9.23%±3.29%
RLN-t	4.26%±1.65%
RLN	2.92%±1.17%

Results for each configuration